AN13047

K32W041AM RF Report for Bluetooth LE and IEEE 802.15.4 Applications

Rev. 0 — 16 November 2022

Application note

Document information

Information	Content
Keywords	K32W041AM RF, Bluetooth LE, IEEE 802.15.4 applications, TX, RX
Abstract	This document provides the K32W041AM RF evaluation test results



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1 Introduction

This document provides the RF evaluation test results of the K32W041AM for:

- Bluetooth Low Energy applications on Two Frequency Shift Keying (2FSK) modulation
- IEEE 802.15.4 applications (OQPSK modulation)

It includes the test setup description and the tools used to perform the tests. To get the K32W041AM radio parameters, see the K32W041AM Data Sheet (document K32W041AM).

2 Bluetooth LE applications

2.1 Test presentation

2.1.1 List of tests

Conducted tests on K32W041AM:

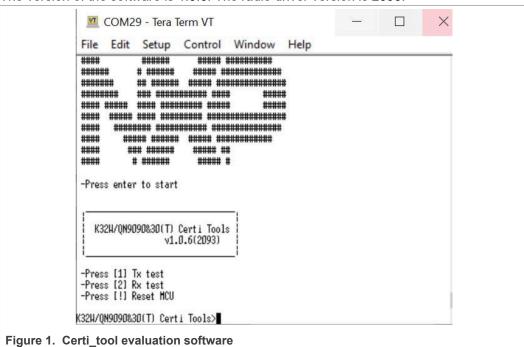
- TX tests:
 - Bench setup
 - Frequency accuracy
 - Phase noise
 - TX power
 - TX power in band
 - TX spurious (H2 to H5, ETSI, and FCC)
 - Upper band edge
 - Modulation characteristics
 - Carrier frequency offset and drift
- RX tests:
 - Bench setup
 - Sensitivity
 - Receiver maximum input level
 - RX spurious (from 30 MHz to 12.5 GHz)
 - Receiver interference rejection performances
 - C/I and receiver selectivity performances
 - Receiver blocking
 - Blocking interferers
 - Intermodulation
- Return loss (S11):
 - RX
 - **–** TX

2.1.2 Software

Before the measurements, load a binary code (connectivity software) in the flash memory of the board. The connectivity tool supports receiver and transmitter functions of the device.

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The version of the software is 1.0.6. The radio driver version is 2093.



2.1.3 List of equipment

The list of equipment used for the RX and TX measurements are as follows:

- DK6 board and a K32W module with SMA connector (same design as modules with an M10 printed antenna)
- R&S SMBV100A signal generator
- R&S FSV spectrum analyzer 13 GHz for harmonic measurements up to H5
- R&S ZND vector network analyzer for S11 measurements
- R&S RF shielded box (to avoid interferences)
- · PC equipped with a GPIB card

2.2 Test summary

RF PHY Bluetooth test specification: RF-PHY.TS.4.2.0 (2014-12-09)

The list of measurements is given in <a>Table 1 for Europe and <a>Table 2 for the US:

Table 1. List of tests for Europe

Name	Measurements	Reference	Limit	Status
Transmission	TX maximum power	Bluetooth LE 4.2, BV-01-C	-20 dBm ≤ PAVG ≤ +10 dBm EIRP	PASS
		Bluetooth LE 5.0	20 dBm ≤ PAVG ≤ +20 dBm EIRP	

Table 1. List of tests for Europe...continued

Name	Measurements	Reference	Limit	Status
	TX power in band	Bluetooth LE 4.2, BV-03-C	PTX <= -20 dBm for (fTX +/- 2 MHz) PTX <= -20 dBm for (fTX +/-4 MHz and +/-5 MHz)	PASS
		Bluetooth LE 5.0	PTX <= -30 dBm for (fTX +/- [3 + n] MHz]); PTX <= -30 dBm for (fTX +/- [6+n] MHz)	
	Modulation characteristics	Bluetooth LE 4.2, BV-05-C	225 kHz <= delta f1avg <= 275 kHz	PASS
		Bluetooth LE 5.0	450 kHz <= delta f1avg <= 550 kHz	
	Carrier frequency offset and drift	Bluetooth LE 4.2, BV-06-C Bluetooth LE 5.0	fTX – 150 kHz <= fn <= fTX + 150 kHz where fTX is the nominal transmit frequency and n=0,1,2,3k f0 – fn <= 50 kHz where n=2,3,4k	PASS
	Spurious 30 MHz – 1 GHz	ETSI EN 300 328	-36 dBm or -54 dBm (depends on frequency) (100 kHz BW)	PASS
	Spurious 1 GHz - 12.5 GHz	ETSI EN 300 328	-30 dBm (1 MHz BW)	PASS
	Eirp TX spectral	ETSI EN 300 328	10 dBm/MHz	FAIL
	density	FCC part 15.247	8 dBm/3 kHz	PASS
	Phase noise (unspread)	NA	NA	For information
Reception	RX sensitivity	Bluetooth LE 4.2, BV-01-C Bluetooth LE 5.0	Packet Error Rate (PER) 30.8 % with a minimum of 1500 packets	PASS
	Co-channel	Bluetooth LE 4.2, BV-03-C Bluetooth LE 5.0	> 21 dB	PASS
	Adjacent channel interference rejection (N +/-1,2,3+MHz)	Bluetooth LE 4.2, BV-03-C Bluetooth LE 5.0	> 15 dB, -17 dB, -27 dB	PASS

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Table 1. List of tests for Europe...continued

Name	Measurements	Reference	Limit	Status
	Blocking interferers	Bluetooth LE 4.2, BV-04-C Bluetooth LE 5.0	-30 dBm / -35 dBm	PASS ^[1]
	Intermodulation performance	Bluetooth LE 4.2, BV-05-C Bluetooth LE 5.0	PER 30.8 % with a minimum of 1500 packets	PASS
	RX maximum input level	Bluetooth LE 4.2, BV-06-C Bluetooth LE 5.0	PER 30.8 % with a minimum of 1500 packets	PASS
	RX emissions 30 MHz – 1 GHz	ETSI EN 300 328	-57 dBm (100 kHz)	PASS
	RX emissions 1 GHz - 12.5 GHz	ETSI EN 300 328	-47 dBm (1 MHz)	PASS
Miscellaneous	Return loss (S11)	Return loss in TX mode	For info	ormation
		Return loss in RX mode		

^[1] Blockers below 2399 GHz and above 2484 GHz are not measured in this report.

Table 2. List of tests for the US

Name	Measurements	Reference	Limit	Status
Transmission	TX maximum power	FCC part 15.247	PAVG ≤ 100 mW +20 dBm EIRP	PASS
	Spurious 1 GHz - 12.5 GHz	FCC part 15.249	Field strength < 50 mV/m at 3 m	PASS
			-41.12 dBm (1 MHz BW)	

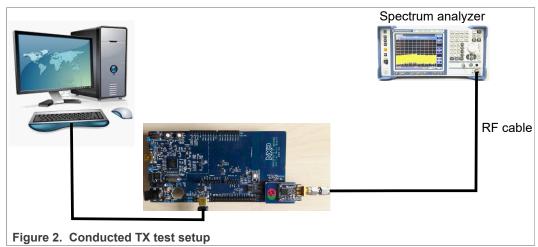
2.3 TX conducted tests

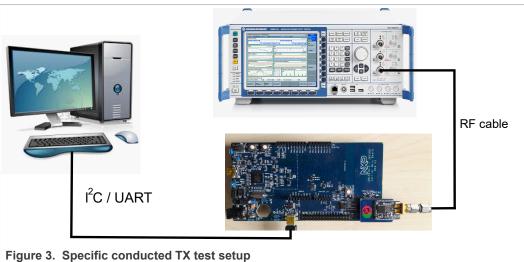
This section lists the details about TX tests.

2.3.1 TX test setup

Figure 2 and Figure 3 show the TX test setups.

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2.3.2 Test results

The test results for the TX conducted tests are as follows:

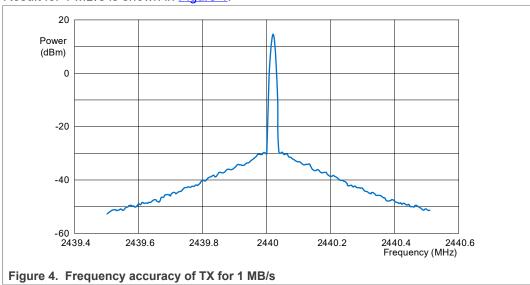
2.3.2.1 Frequency accuracy

Test method:

- 1. Set the radio to:
 - TX mode
 - CW
 - Continuous mode
 - Frequency: Channel 19
- 2. Set the analyzer to:
 - Center frequency = 2.44 GHz
 - Span = 1 MHz
 - Ref amp = 20 dBm
 - RBW = 10 kHz
 - VBW = 100 kHz
- 3. Measure the CW frequency with the marker of the spectrum analyzer.

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Result for 1 MB/s is shown in Figure 4:

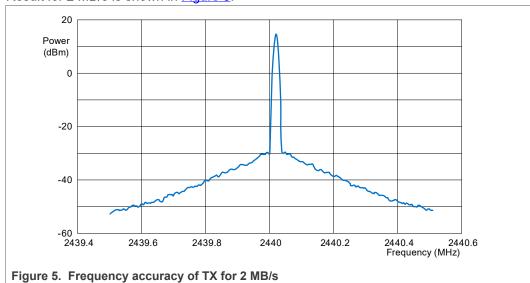


- Measured frequency = 2.440014 GHz
- ppm value = +5.8 ppm

Table 3. Frequency accuracy

Result	Target
+5.8 ppm	+/-25 ppm

Result for 2 MB/s is shown in Figure 5:



- Measured frequency = 2.4440018 GHz
- ppm value = +7.4 ppm

Table 4. Frequency accuracy

Result	Target
+7.4 ppm	+/-25 ppm

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Note: The frequency accuracy depends on the XTAL model.

Conclusion:

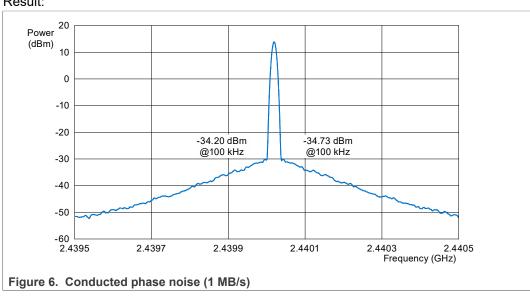
• The frequency accuracy complies with the data sheet.

2.3.2.2 Phase noise

Test method:

- 1. Set the radio to:
 - TX mode
 - CW
 - · Continuous mode
 - Frequency: Channel 19
- 2. Set the analyzer to:
 - Center frequency = 2.44 GHz
 - Span = 1 MHz
 - Ref amp = 20 dBm
 - RBW = 10 kHz
 - VBW = 100 kHz
- 3. Measure the phase noise at the 100 kHz offset frequency:
 - RBW (spectrum analyzer) = 10 kHz (20 log (10 kHz) = 40 dBc)

Result:



• Marker value (delta) = -34.20 dBm / RBW 10 kHz = -74.20 dBc/Hz

Note: The phase noise is just for informational purposes. No specific issue on this parameter.

Conclusion:

• The result is the same for 2 MB/s data rate.

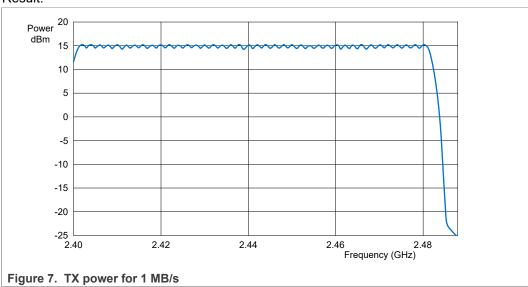
2.3.2.3 TX power (fundamental)

Test method:

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- 1. Set the radio to:
 - TX mode 1 M
 - Unmodulated
 - Continuous mode (00)
- 2. Set the analyzer to:
 - Start frequency = 2.4 GHz
 - Stop frequency = 2.5 GHz
 - Ref amp = 20 dBm
 - Sweep time = 11.3 μs
 - RBW = 3 MHz
 - VBW = 3 MHz
 - · Maximum Hold mode
 - Detector = RMS
- 3. Sweep all the channels from channel 0 to channel 39.

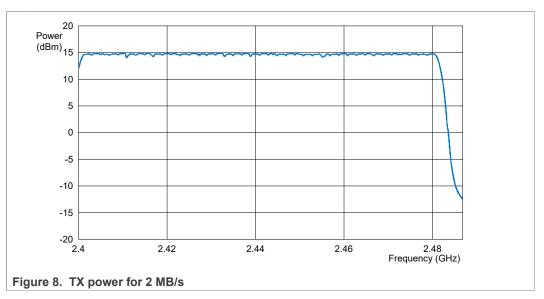
Result:



- Maximum power is on channel 36: 15.25 dBm
- Minimum power is on channel 26: 15.08 dBm
- Tilt over frequencies is 0.17 dB

The same test is performed when setting 2 MB/s. Figure 8 shows the result:

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- Maximum power is on channel 8: 14.92 dBm
- Minimum power is on channel 36: 14.80 dBm
- Tilt over frequencies is 0.12 dB

Conclusion:

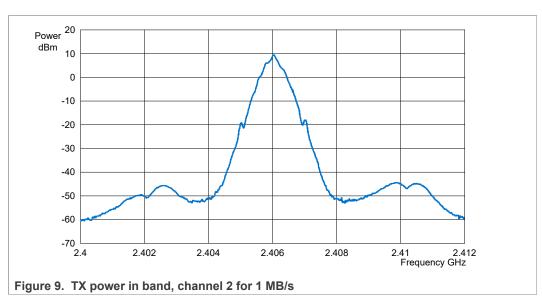
- The default transmit output power is in line with the expected results.
- The power is flat over frequencies.

2.3.2.4 TX power in band

Test method:

- 1. Set the radio to:
 - TX mode
 - Modulated
 - · Continuous mode
- 2. Set the analyzer to:
 - Start frequency = 2.35 GHz
 - Stop frequency = 2.5 GHz
 - Ref amp = 20 dBm
 - Sweep time = 100 ms
 - RBW = 100 kHz
 - VBW = 300 kHz
 - Maximum Hold mode
 - Detector = RMS
 - Number of sweeps = 10
- 3. Sweep on channel 2, channel 19, and channel 37

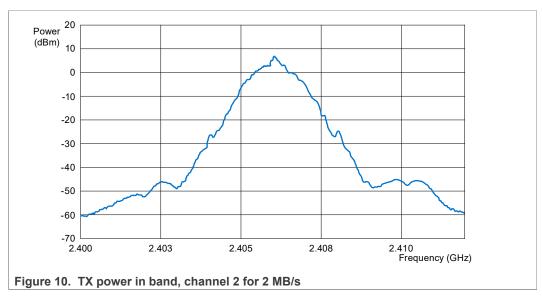
Result:



<u>Table 5</u> shows the statistics on 1 MHz bandwidth using CMW270 equipment measurement:

Table 5. For 1 MB/s

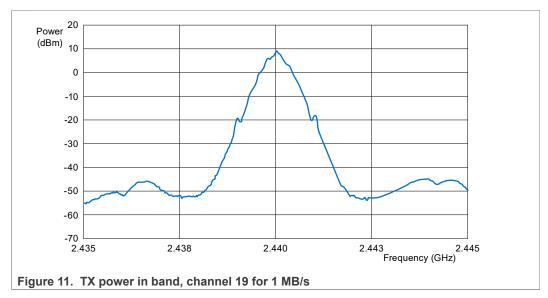
Bandwidth	Specification	Measurement (dBm)
Max peak level <= -2 MHz	-20	-47.2
Max peak level >= +2 MHz	-20	-43.8
Max peak level <= -3 MHz	-30	-43.5
Max peak level >= +3 MHz	-30	-44.5



<u>Table 6</u> shows the statistics on 1 MHz bandwidth using CMW270 equipment measurement:

Table 6. For 2 MB/s

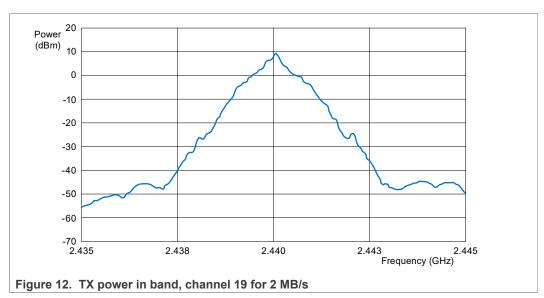
Bandwidth	Specification	Measurement (dBm)
Max peak level <= -4 MHz	-20	-44.0
Max peak level >= +4 MHz	-20	-42.4
Max peak level <= -6 MHz	-	-
Max peak level >= +6 MHz	-30	-49.0



<u>Table 7</u> shows the statistics on 1 MHz bandwidth using CMW270 equipment measurement:

Table 7. For 1 MB/s

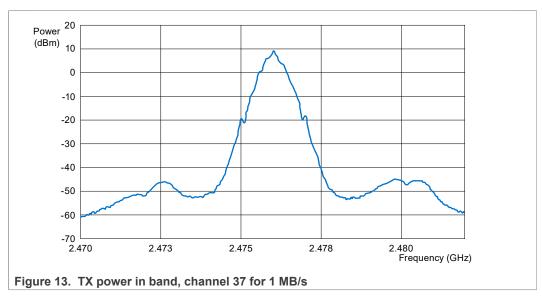
Bandwidth	Specification	Measurement (dBm)
Max peak level <= -2 MHz	-20	-43.5
Max peak level >= +2 MHz	-20	-43.6
Max peak level <= -3 MHz	-30	-48.4
Max peak level >= +3 MHz	-30	-45.1



<u>Table 8</u> shows the statistics on 1 MHz bandwidth using CMW270 equipment measurement:

Table 8. For 2 MB/s

Bandwidth	Specification	Measurement (dBm)
Max peak level <= -4 MHz	-20	-44.3
Max peak level >= +4 MHz	-20	-42.7
Max peak level <= -6 MHz	-30	-48.5
Max peak level >= +6 MHz	-30	-49.3

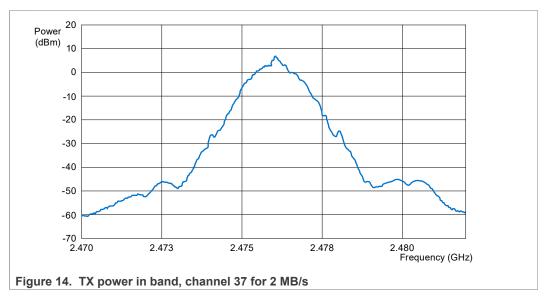


<u>Table 9</u> shows the statistics on 1 MHz bandwidth using CMW270 equipment measurement:

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Table 9. For 1 MB/s

Bandwidth	Specification	Measurement (dBm)
Max peak level <= -2 MHz	-20	-43.1
Max peak level >= +2 MHz	-20	-43.6
Max peak level <= -3 MHz	-30	-48.1
Max peak level >= +3 MHz	-30	-44.9



<u>Table 10</u> shows the statistics on 1 MHz bandwidth using CMW270 equipment measurement:

Table 10. For 2 MB/s

Bandwidth	Specification	Measurement (dBm)
Max peak level <= -4 MHz	-20	-45.5
Max peak level >= +4 MHz	-20	-43.3
Max peak level <= -6 MHz	-30	-49.8
Max peak level >= +6 MHz	-	-

Conclusion:

• These results are compliant to Bluetooth LE 4.2 and Bluetooth LE 5.0.

2.3.2.5 TX spurious

2.3.2.5.1 30 MHz to 12.5 GHz

Spurious overview of the full band from 30 MHz to 12.5 GHz when the device is in the transmission mode is as follows:

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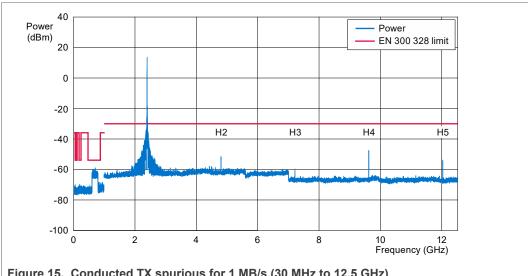
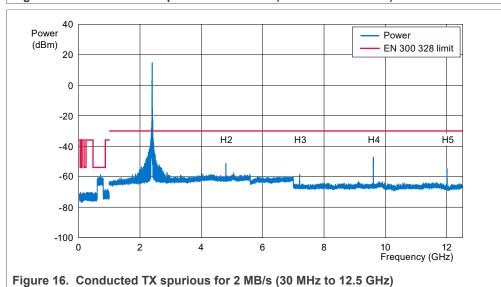


Figure 15. Conducted TX spurious for 1 MB/s (30 MHz to 12.5 GHz)



Conclusion:

- There are no TX spurs above the EN 300 328 limit (more than 10 dB margin).
- Harmonics are measured in the following sections. Since there is no major change between 1 MB/s and 2 MB/s spurious, they are measured at 1 MB/s.

2.3.2.5.2 H2 (ETSI test conditions, peak measurement)

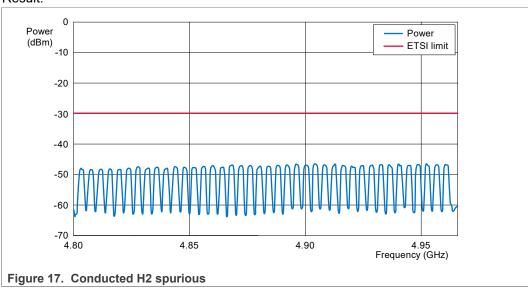
Test method:

- 1. Set the radio to:
 - TX mode
 - Modulated
 - · Continuous mode
- 2. Set the analyzer to:
 - Start frequency = 4.7 GHz
 - Stop frequency = 5 GHz
 - Ref amp = -20 dBm

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- Sweep time = 100 ms
- RBW = 1 MHz
- VBW = 3 MHz
- · Maximum Hold mode
- · Detector: Peak
- 3. Sweep all the channels from channel 0 to channel 39.

Result:



• Maximum power at channel 38 is -46.3 dBm

Conclusion:

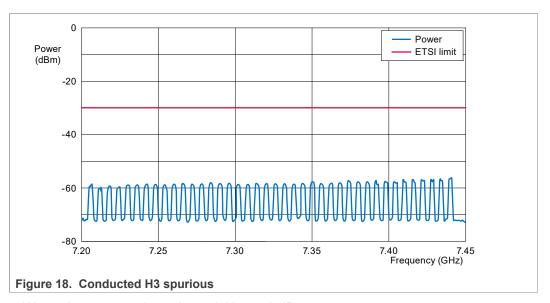
• There is 16.3 dB margin to the ETSI limit.

2.3.2.5.3 H3 (ETSI test conditions, peak measurement)

The test method is the same as for the H2, except the spectrum analyzer frequency start/ stop is set to 7.0 GHz and 7.5 GHz.

Result:

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• H3 maximum power is at channel 40: -55.8 dBm

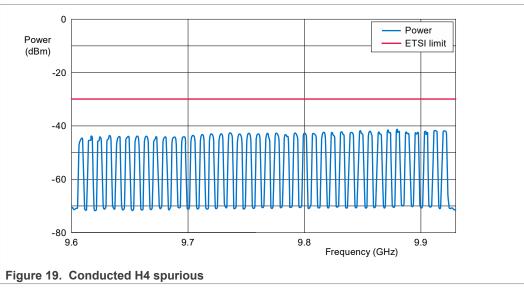
Conclusion:

• There is 25.8 dB margin to the ETSI limit.

2.3.2.5.4 H4 (ETSI test conditions, peak measurement)

The test method is the same as for the H2, except that the spectrum analyzer frequency span is set from 9.4 GHz to 10.0 GHz.

Result:



• Maximum power is at channel 35: -41.7 dBm

Conclusion:

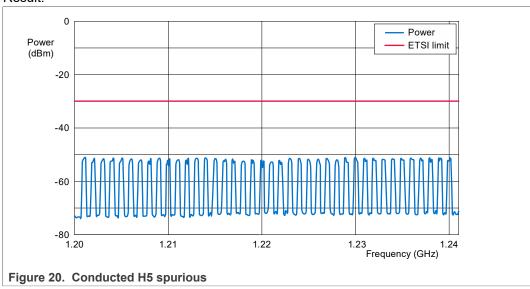
• There is 11.7 dB margin to the ETSI limit.

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2.3.2.5.5 H5 (ETSI test conditions, peak measurement)

The test method is the same as for the H2, except that the spectrum analyzer frequency span is set from 11.7 GHz to 12.5 GHz.

Result:



• Maximum power is at channel 30: -51.0 dBm

Conclusion:

• There is 21.0 dB margin to the ETSI limit.

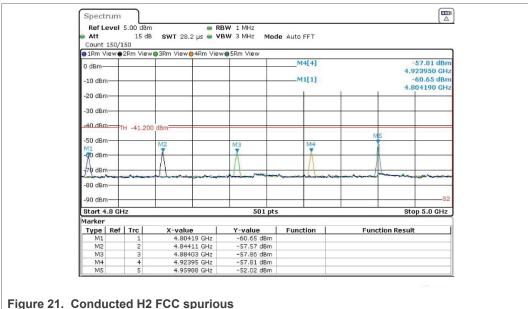
2.3.2.5.6 H2 (FCC test conditions, average measurements)

Test method:

- 1. Set the radio to:
 - TX mode
 - Modulated
 - · Continuous mode
- 2. Set the analyzer to:
 - Start frequency = 4.7 GHz
 - Stop frequency = 5 GHz
 - Sweep time = 100 ms
 - RBW = 1 MHz
 - VBW = 3 MHz
 - Trace: Maximum Hold mode
 - Detector: RMS
- 3. Sweep all the channels from channel 0 to channel 39. For this case and in the next sections, only 4 is represented.

Result:

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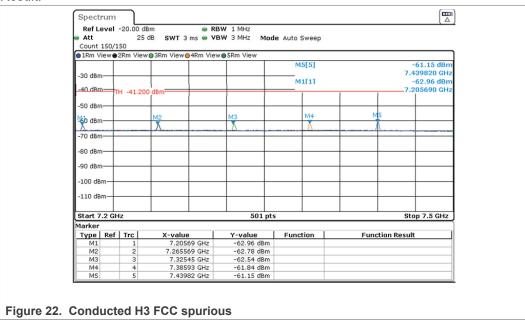
Conclusion:

• There is around 11.2 dB margin to the FCC limit.

2.3.2.5.7 H3 (FCC test conditions, average measurements)

The test method is the same as for the H2, except that the spectrum analyzer frequency span is set from 7.0 GHz to 7.5 GHz.

Result:



• Power is -66 dBm below noise floor of this measurement.

Conclusion:

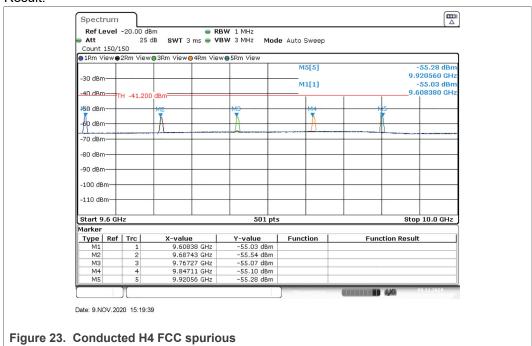
• There is 20 dB margin to the FCC limit.

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2.3.2.5.8 H4 (FCC test conditions, average measurements)

The test method is same as for the H2, except that the spectrum analyzer frequency span is set from 9.4 GHz to 10 GHz.

Result:



Conclusion:

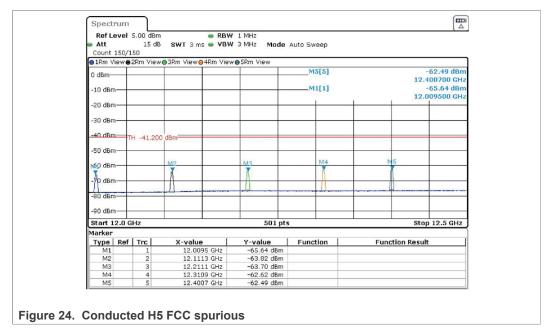
• There is around 14 dB margin to the FCC limit.

2.3.2.5.9 H5 (FCC test conditions, average measurements)

The test method is same as for the H2, except that the spectrum analyzer frequency span is set from 11.7 GHz to 12.5 GHz.

Result:

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Conclusion:

• There is around 21 dB margin to the FCC limit.

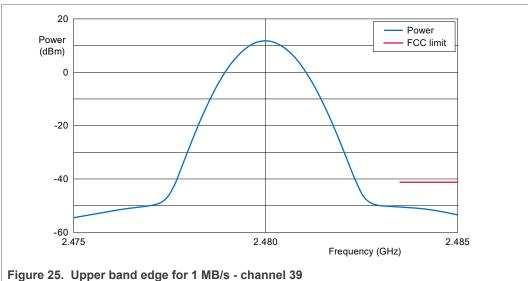
2.3.2.6 Upper band edge

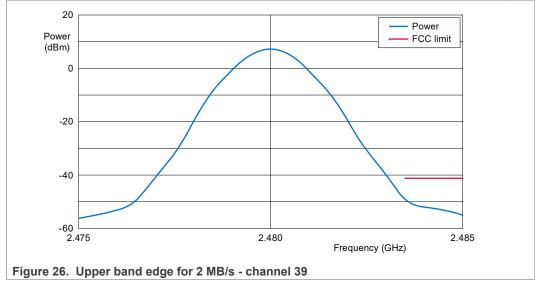
Test method:

- 1. Set the radio to:
 - TX mode
 - Modulated
 - · Continuous mode
- 2. Set the analyzer to:
 - Start frequency = 2.475 GHz
 - Stop frequency = 2.485 GHz
 - Ref amp = 20 dBm
 - Sweep time = 100 ms
 - RBW = 1 MHz
 - VBW = 3 MHz
 - Detector = Average
 - Average mode = Power
 - Number of sweeps = 100
 - Set the channel 39 (2.48 GHz)

Results:

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Conclusion:

- The upper band edge test passes the FCC certification.
- There is 9.0 dB margin for 1 MB/s and 8.5 dB margin for 2 MB/s to the FCC limit.

2.3.2.7 Modulation characteristics

A CMW equipment is used to measure the frequency deviation df1 and df2.

A specific binary is flashed: hci blackbox bm.bin (version V1) from the SDK.

Test method:

- Generator for the desired signal: CMW R&S
- Criterion: PER < 30.8 % with 1500 packets
- Channels under test: 0, 19, and 39

Result:

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Table 11. Modulation characteristics at 1 MB/s

Frequency	(Channel number	r	Specifi	ication
deviation	0	19	39	min	max
Frequency deviation df1 Average (kHz)	251.67	251.27	251.36	225	275
Frequency deviation df2 99.9 % (kHz)	212.64	213.04	212.04	185	-
Frequency deviation df2 Average / df1 Average	0.9	0.91	0.9	0.8	-

Table 12. Modulation characteristics at 2 MB/s

Frequency	(Channel numbe	r	Specif	ication
deviation	0	19	39	min	max
Frequency deviation df1 Average (kHz)	501.09	502.32	503.97	450	550
Frequency deviation df2 99.9 % (kHz)	425.07	431.27	422.87	370	-
Frequency deviation df2 Average / df1 Average	0.88	0.89	0.88	0.8	-

Conclusion: The margins are good and in line with the expected results.

2.3.2.8 Carrier frequency offset and drift

A CMW equipment is used to measure the frequency deviation df1 and df2. A specific binary is flashed: hci blackbox bm.bin (version V1) from the SDK.

Test method:

- Generator for the desired signal: CMW270 R&S
- Criterion: PER < 30.8 % with 1500 packets
- Channels under test: 0, 19, and 39

Result:

Table 13. Carrier frequency offset and drift at 1 MB/s

Frequency	Channel number		Specification		
offset and drift	0	19	39	min	max
Frequency drift (kHz)	-10.06	-10.24	-11.16	-50	50

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Table 13. Carrier frequency offset and drift at 1 MB/s...continued

Frequency		Channel numbe	r	Specif	ication
offset and drift	0	19	39	min	max
Max drift rate (kHz/50 μs)	-3.37	-3.47	-3.34	-20	20
Frequency offset (kHz)	22.18	22.84	23.67	-150	150
Initial frequency drift (kHz)	-8.19	-8.29	-9.45	-23	23

Table 14. Carrier frequency offset and drift at 2 MB/s

Frequency	(Channel number	r	Specifi	ication
offset and drift	0	19	39	min	max
Frequency drift (kHz)	-8.06	-8.89	-10.41	-50	50
Max drift rate (kHz/50 µs)	-4.72	-2.86	-2.71	-20	20
Frequency offset (kHz)	21.12	22.13	24.02	-150	150
Initial frequency drift (kHz)	-4.55	-6.37	-7.62	-23	23

Conclusion:

• Margins are good and in line with the expected results.

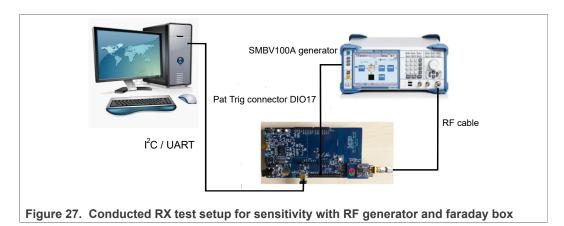
For next receiver measurements below, the software used is the connectivity tool 1.0.6.

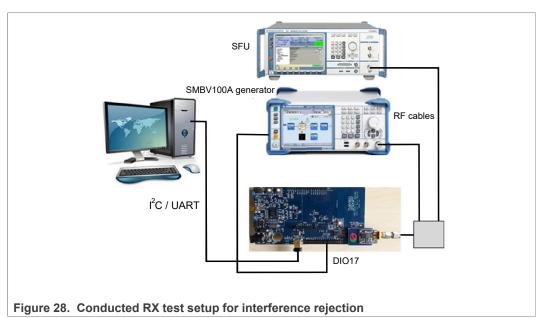
2.4 RX tests

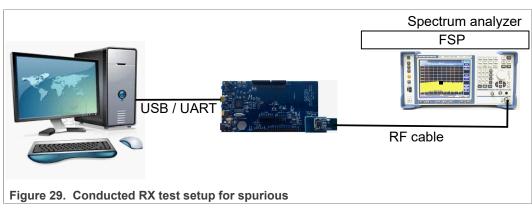
This section lists the details about RX tests.

2.4.1 Test setup

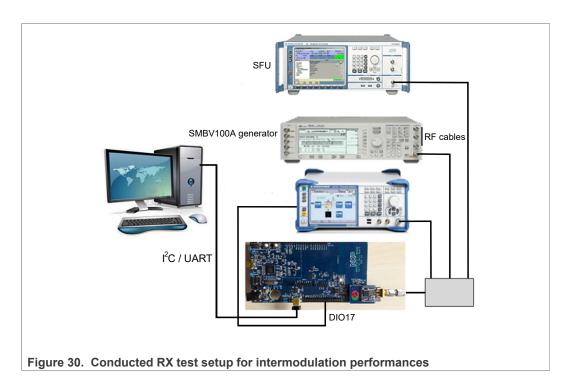
The Module and DK6 board must be placed into an RF shielded box. <u>Figure 27</u> to <u>Figure 30</u>, shows the conducted RX test setups.







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2.4.2 RX sensitivity

Test method:

To remain immune to the external parasitic signals, DK6 board is kept in an RF shielded box.

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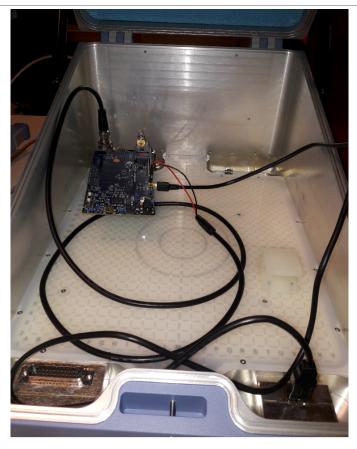


Figure 31. Sensitivity test

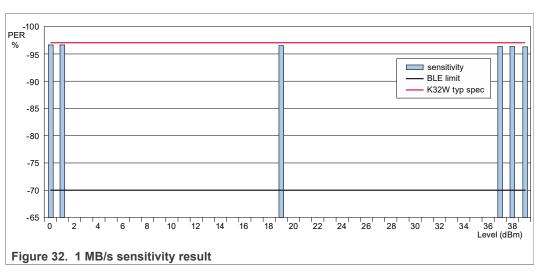
The generator (SMBV100A) is used in the ARB mode to generate a pattern of 1500 packets (DIO17 of DK6 connected to signal generator Trig in). The TERATERM window is used to control the module.

- 1. Set it to channel 0
- 2. The connection is automatically established and the Packet Error Rate (PER) is measured
- 3. Decrease the level of the SMBV at the RF input of the module until PER = 30.8 %
- 4. Repeat it up to channel 39

The results of the few manually measured channels are as follows:

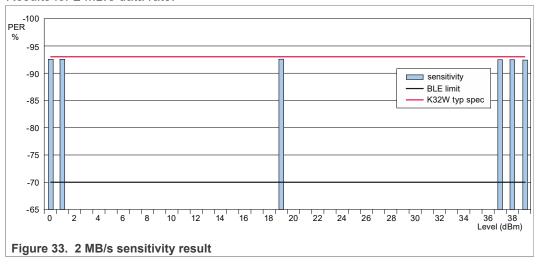
Results for 1 MB/s data rate:

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- The best sensitivity is on channel 1: -96.7 dBm
- The lowest sensitivity is: -96.3 dB
- Delta over channels: 0.4 dB

Results for 2 MB/s data rate:



- The best sensitivity is on channel 0, 1, 19: -92.7 dBm
- The lowest sensitivity is: -92.6 dB
- Delta over channels: 0.1 dB

Conclusion:

• Sensitivity average value is -96.5 dBm for 1 MB/s and -92.7 dBm for 2 MB/s. These results are in line with characterization results.

2.4.3 Receiver maximum input level

Test method:

- The test setup is the same as for the sensitivity test.
- The signal level is increased up to the PER = 30.8 % with 1500 packets.

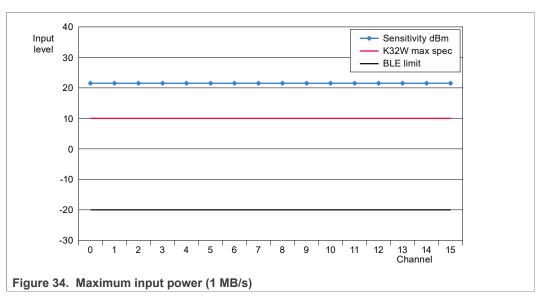
Results at 1 MB/s:

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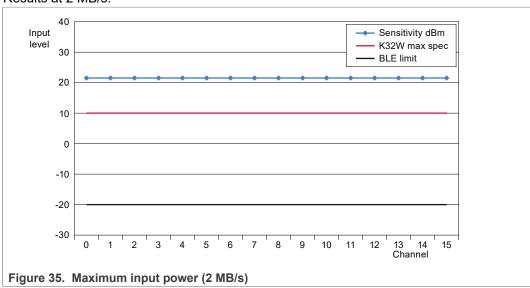
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Results at 2 MB/s:



Conclusion:

- The data sheet specified value is only for the information purpose.
- According to the test results from above, there is a margin to increase the input power level up to 20 dBm.
- Therefore, from a system perspective, these results are consistent with the expected values.

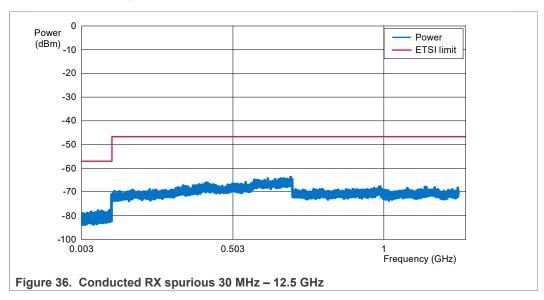
2.4.4 RX spurious

Test method:

- 1. Set the radio to:
 - Receiver mode

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- Frequency: Channel 18
- 2. Set the analyzer to:
 - Ref amp = -20 dBm
 - Trace = Max Hold
 - Detector = Max Peak
 - Start/stop frequency = 30 MHz/1 GHz
 - RBW = 100 kHz, VBW = 300 kHz
 - Set the start/stop frequency = 1 GHz/12.5 GHz
 - RBW = 1 MHz, VBW = 3 MHz



Conclusion:

- There are no spurs above the spectrum analyzer noise floor.
- More than 13 dB margin.

2.4.5 Receiver interference rejection performances

2.4.5.1 Adjacent, alternate, and co-channel rejection

The interferers are at the adjacent channel (+/-1 MHz, +/-2 MHz, +/-3 MHz) or co-channel. The test is performed with only one interfering unmodulated signal at a time.

Test method:

- · Generator for the desired signal: SMBV100A
- · Generator for interferers: R&S SFU
- Criterion: PER < 30.8 % with 1500 packets
- The wanted signal is set to -67 dBm; the interferer is increased until the PER threshold is reached
- Channel under test = 2

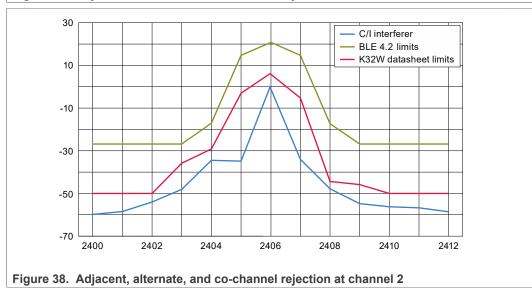
Results for 1 MB/s:

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		cl	12	
		24	06	
	n-2 MHz	n-1 MHz	n+1 MHz	n+2 MHz
	2404	2405	2407	2408
Interferer Read value	-27.4	-26.9	-27.7	-13.9
Interferer level (dBm)	-32.4	-31.9	-32.7	-18.9
Interferer level (C/I dB)	-34.6	-35.1	-34.3	-48.1
BLE 4.2 limit (C/I dB)	-17	15	15	-17
Margin (dB)	17.6	50.1	49.3	31.1

	cl	12
	24	06
	n-3 MHz	n+3 MHz
	2403	2409
Interferer Read value	-13.7	-7.5
Interferer level (dBm)	-18.7	-12.5
Interferer level (C/I dB)	-48.3	-54.5
BLE 4.2 limit (C/I dB)	-27	-27
Margin (dB)	21.3	27.5

Figure 37. Adjacent, alternate, and co-channel rejection



Results for 2 MB/s:

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		cl	12	
		24	06	
	n-4 MHz	n-2 MHz	n+2 MHz	n+4 MHz
	2402	2404	2408	2410
Interferer Read value	-32.0	-26.9	-22	-13.4
Interferer level (dBm)	-37.0	-31.9	-27.0	-18.4
Interferer level (C/I dB)	-30.0	-35.1	-40.0	-48.6
BLE 5.0 limit (C/I dB)	-17	15	15	-17
Margin (dB)	13.0	50.1	55.0	31.6

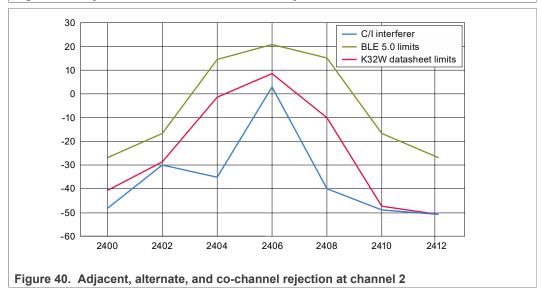
	cł	12
	24	06
	n-6 MHz	n+6 MHz
	2400	2412
Interferer Read value	-13.7	-11.5
Interferer level (dBm)	-18.7	-16.5
Interferer level (C/I dB)	-48.3	-50.5
BLE 5.0 limit (C/I dB)	-27	-27
Margin (dB)	21.3	23.5

Co-channel

ch2
2406

n
2406
-65.1
-70.1
3.1
21
17.9

Figure 39. Adjacent, alternate, and co-channel rejection



Conclusion:

- The shape of the curve is due to CW interferer.
- The results are compliant with the K32W specification and Bluetooth LE limits.

2.4.5.2 Receiver Blocking

The blocking interferers are positioned at the out of band channels depending on the receiver category.

2.4.5.2.1 Receiver category 2

The test is performed with only one interfering signal at a time, for more details see the ETSI 300.328 2.1.1 chapter 4.3.1.12.4.3)

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Test method:

- Generator for the desired signal: R&S SMBV100
- · Generator for interferers: R&S SFU
- Criterion: PER < 10 % (sensitivity at 10 % PER must be measured before)
- The wanted signal is set to Pmin at 10 % PER + 6 dB; the interferer is increased until the PER threshold is reached
- · Channels under test: 0 and 39
- Test is performed for 1 MB/s then for 2 MB/s

Result for 1 MB/s:



Figure 41. Receiver blocking (out of band) rejection for 1 MB/s (Pmin at 10 % PER + 6 dB = -90.0 dBm)

Result for 2 MB/s:

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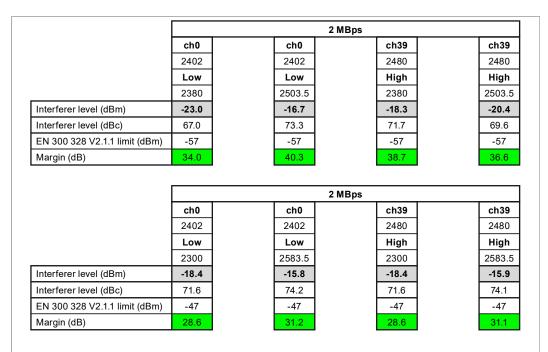


Figure 42. Receiver blocking (out of band) rejection for 2 MB/s (Pmin at 10 % PER + 6 dB = -86.3 dBm)

Conclusion:

• There is a good margin to ETSI specification for blockers category 2.

2.4.5.3 Intermodulation

This test verifies that the receiver intermodulation performance is adequate. Two interferers are used in combination with the desired signal. The first interferer is a sinusoid non-modulated signal and the second interferer is a modulated signal with PRSB15 data.

Test method:

- Generator for the desired signal: R&S SMBV100A
- Generator for the first interferer (CW): Agilent E4438
- Generator for the second interferer (PRBS15): R&S SFU
- Criterion: PER < 30.8 % with 1500 packets
- The wanted signal is set to -64 dBm
- Channels under test: 0, 19 and 39

Results for 1 MB/s:

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	ch0	ch0	ch0	ch0	ch0	ch0
	2402	2402	2402	2402	2402	2402
	Low	Low	Low	Low	Low	Low
Interferer1 (CW) (MHz)	-5	-4	-3	3	4	5
Interferer2 (Mod) (MHz)	-10	-8	-6	6	8	10
Interferer level (dBm)	-29.7	-28.7	-29.0	-22.3	-26.9	-28.9
Interferer level (dBc)	34.3	35.3	35.0	41.7	37.1	35.1
Datasheet limit (dBm)	-30	-29	-27	-27	-29	-30
Margin (dB)	9.5	9.5	7.2	13.9	11.3	10.3
	ch19	ch19	ch19	ch19	ch19	ch19
	2440	2440	2440	2440	2440	2440
	Mid	Mid	Mid	Mid	Mid	Mid
Interferer1 (CW) (MHz)	-5	-4	-3	3	4	5
Interferer2 (Mod) (MHz)	-10	-8	-6	6	8	10
Interferer level (dBm)	-30.0	-29.0	-29.3	-22.4	-27.2	-29.0
Interferer level (dBc)	34.0	35.0	34.7	41.6	36.8	35.0
Datasheet limit (dBm)	-30	-29	-27	-27	-29	-30
Margin (dB)	9.2	9.2	6.9	13.8	11.0	10.2
	ch39	ch39	ch39	ch39	ch39	ch39
	2480	2480	2480	2480	2480	2480
	High	High	High	High	High	High
Interferer1 (CW) (MHz)	-5	-4	-3	3	4	5
Interferer2 (Mod) (MHz)	-10	-8	-6	6	8	10
Interferer level (dBm)	-29.7	-28.7	-29.0	-22.2	-27.8	-28.8
Interferer level (dBc)	34.3	35.3	35.0	41.8	36.2	35.2
Datasheet limit (dBm)	-30	-29	-27	-27	-29	-30
Margin (dB)	9.5	9.5	7.2	14.0	10.4	10.4

Figure 43. Intermodulation results for 1 MB/s

Results for 2 MB/s:

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	ch0	ch0	ch0	ch0	ch0	ch0
	2402	2402	2402	2402	2402	2402
	Low	Low	Low	Low	Low	Low
Interferer1 (CW) (MHz)	-10	-8	-6	6	8	10
Interferer2 (Mod) (MHz)	-20	-16	-12	12	16	20
Interferer level (dBm)	-29.2	-31.3	-31.2	-30.7	-30.7	-30.2
Interferer level (dBc)	34.8	32.7	32.8	33.3	33.3	33.8
Datasheet limit (dBm)	-30.5	-32.5	-32	-32	-32.5	-30.5
Margin (dB)	10.5	10.4	10.0	10.5	11.0	9.5
	ch19	ch19	ch19	ch19	ch19	ch19
	2440	2440	2440	2440	2440	2440
	Mid	Mid	Mid	Mid	Mid	Mid
Interferer1 (CW) (MHz)	-10	-8	-6	6	8	10
Interferer2 (Mod) (MHz)	-20	-16	-12	12	16	20
Interferer level (dBm)	-29.2	-31.3	-31.4	-30.9	-30.5	-30.3
Interferer level (dBc)	34.8	32.7	32.6	33.1	33.5	33.7
Datasheet limit (dBm)	-30.5	-32.5	-32	-32	-32.5	-30.5
Margin (dB)	10.5	10.4	9.8	10.3	11.2	9.4
	ch39	ch39	ch39	ch39	ch39	ch39
	2480	2480	2480	2480	2480	2480
	High	High	High	High	High	High
Interferer1 (CW) (MHz)	-10	-8	-6	6	8	10
Interferer2 (Mod) (MHz)	-20	-16	-12	12	16	20
Interferer level (dBm)	-29.0	-31.0	-31.0	-30.6	-30.5	-29.9
Interferer level (dBc)	35.0	33.0	33.0	33.4	33.5	34.1
Datasheet limit (dBm)	-30.5	-32.5	-32	-32	-32.5	-30.5
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Figure 44. Intermodulation results for 2 MB/s

Conclusion:

• The results are compliant with the specified values from data sheet.

2.5 Return loss

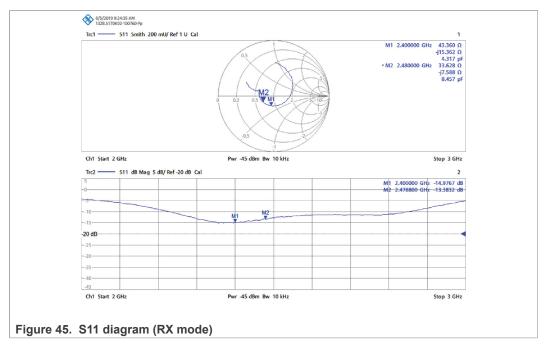
The SMA connector is used for the measurements.

2.5.1 RX

In the RX mode, the return loss measurement is performed by setting the LNA gain of K32W to the maximum.

Hardware: DK6 board

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Results:

• Return loss: -15.0 dB (2.4 GHz) < S11 < -13.3 dB (2.48 GHz)

Note: There is no specification for the return loss.

Conclusion:

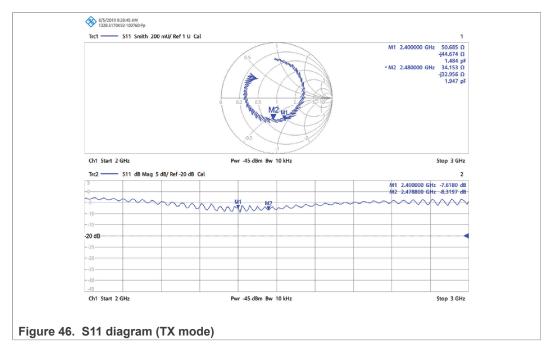
• The return loss (S11) is lower than -10 dB.

2.5.2 TX

In the TX mode, the return loss measurement is performed by setting the K32W RF output power to the minimum.

Hardware: DK6 board

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Results:

• Return loss: -8.3 dBm (2.48 GHz) < S11 < -7.6 dB (2.4 GHz)

Note: There is no specification for the return loss.

Conclusion:

• The return loss (S11) is lower than -7 dB.

2.6 Conclusion

The results are compliant with the specification and Bluetooth Low Energy standard.

3 Applications

3.1 Test presentation

Conducted tests:

3.1.1 List of tests

- 1. TX tests:
 - · Frequency accuracy
 - · Phase noise
 - TX power
 - TX spurious
 - Harmonics
 - EVM and offset EVM

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- · Upper band edge
- 2. RX tests:
 - Sensitivity
 - · Maximum input level
 - · RX spurious
 - LO leakage
 - Interferers (as per IEEE 802.15.4 requirements)
 - Co-channel
 - Receiver blocking (as per ETSI 300 328 requirements)
- 3. Return loss
 - RX

3.1.2 Software

Before the measurement, load a binary code in the flash memory of the board by using the flash programmer application JN-SW-4407. The binary code used for the following tests is the Customer Module Evaluation Tool (CMET) version 2042 compiled on September 21, 2020.

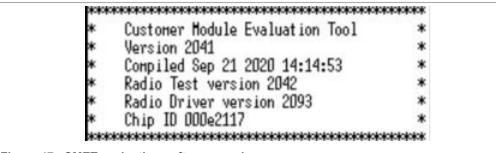


Figure 47. CMET evaluation software version

The TERATERM terminal emulator is used to communicate with the K32W UART0. Two USB ports are available on the DK6 board to control the K32W with CMET: LPC Link2 and FTDI.

Section 5 provides the selected options to perform the following tests.

3.1.3 Test equipment

Spectrum analyzer	Generators
R&S FSP	R&S SFU
R&S FSU	R&S SMBV100A

3.2 Test summary

This section synthetizes in <u>Table 15</u> and <u>Table 16</u> the main tests performed on the K32W modules. Most of the test results and setup details are described in this document. For further information, contact your NXP local contact.

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Table 15. List of tests for Europe

Name	Measurements	Reference	Limit	Status
Transmission	TX maximum power	ETSI EN 300 328	20 dBm, 100 mW (radiated)	PASS
	Eirp TX spectral density	ETSI EN 300 328 FCC part 15.247	10 dBm/MHz 8 dBm/3 kHz	FAIL PASS
	TX spectral density	IEEE 802.15.4_ 2011	-20 dBc or -30 dBm (100 kHZ, f-fc > 3.5 MHz)	PASS
	Spurious 30 MHz – 1 GHz	ETSI EN 300 328	-36 dBm or -54 dBm (depends on frequency) (100 kHz BW)	PASS
	Spurious 1 GHz - 12.5 GHz	ETSI EN 300 328	-30 dBm (1 MHz BW)	PASS
	EVM	IEEE 802.15.4_ 2011	35 %	PASS
	TX frequency tolerance	IEEE 802.15.4_ 2011	+/- 40 ppm	PASS
Reception	Reachable low limit of maximum power	IEEE 802.15.4_ 2011	-3 dBm	PASS
	Phase noise (unspread)	IEEE 802.15.4_ 2003	NA	For information
	RX emissions 30 MHz - 1 GHz	ETSI EN 300 328	-57 dBm (100 kHz)	PASS
	RX emissions 1 GHz - 12.5 GHz	ETSI EN 300 328	-47 dBm (1 MHz)	PASS
	RX sensitivity	IEEE 802.15.4	-85 dBm	PASS
	Adjacent channel interference rejection N+/-1	IEEE 802.15.4_ 2011	0 dB	PASS
	Adjacent channel interference rejection N+/-2	IEEE 802.15.4_ 2011	30 dB	PASS
	Receiver blocking	ETSI EN 300 328	-57 dBm/-47 dBm	PASS
	RX maximum input level	IEEE 802.15.4_ 2011	-20 dBm	PASS
Miscellaneous	Return loss (S11)	Return loss in TX mode Return loss in RX mode	For info	rmation

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Table 16. List of tests for US

Name	Measurements	Reference	Limit	Status
Transmission	Spurious 1 GHz -	FCC part 15	-41.12 dBm	PASS
	12.5 GHz		(1 MHz BW)	

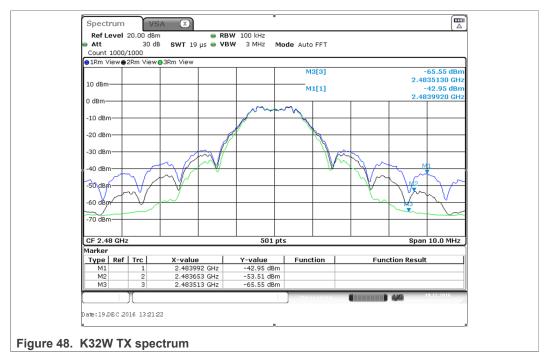
3.3 TX conducted tests

3.3.1 TX modes

Three different modulation modes exist in K32W transmission as follows:

- Regular
- · Proprietary 1
- Proprietary 2

In Regular mode, the whole OQPSK spectrum is transmitted without any filtering. In Proprietary mode 1, the spectrum is slightly digitally filtered and in Proprietary mode 2, the spectrum is more heavily filtered. Filtering the spectrum can be useful to pass the FCC upper band-edge test without reducing the TX power on channel 26. Filtering the TX spectrum also allows the receiver to benefit from its full selectivity performances, see Section 4 for details.



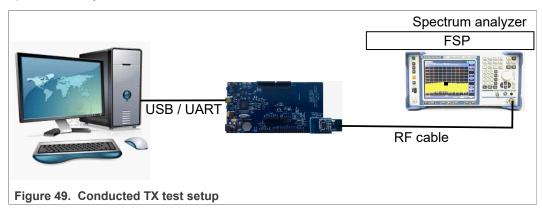
- Blue graph: Regular mode
- Black graph: Proprietary mode 1
- Green graph: Proprietary mode 2

Note: The measurements included in this document have been done in Regular mode otherwise specified.

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3.3.2 Test setup

The TX power of the K32W is set to +15 dBm. Connect the RF port of the module to the spectrum analyzer.



3.3.3 Test results

The test results are as follows:

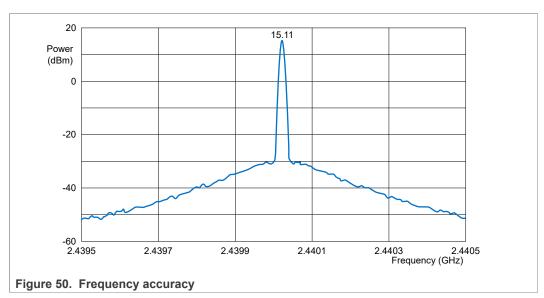
3.3.3.1 Frequency accuracy

Test method:

- 1. Set the radio in:
 - TX mode
 - CW
 - · Continuous mode
 - Frequency: Channel 18
- 2. Set analyzer to:
 - Center frequency = 2.44 GHz
 - Span = 1 MHz
 - Ref amp = 20 dBm
 - RBW = 10 kHz
- 3. Measure the CW frequency with the marker of the spectrum analyzer.

Result:

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- Measured frequency = 2.440022 GHz
- ppm value = 9.0 ppm

Result	Target	IEEE 802.15.4 limit
9.0 ppm	+/- 25 ppm	+/- 40 ppm

Note: The frequency accuracy depends on the XTAL model. The model used on the RF module is NX2016SA EXS00A-CS11213-6pF from NDK.

Conclusion:

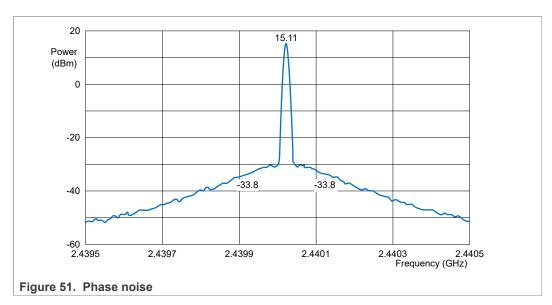
• The channel frequency is correctly centered therefore fully compliant with the IEEE 802.15.4 specifications.

3.3.3.2 Phase noise at 100 kHz offset

Test method:

- 1. Set the radio in:
 - TX mode
 - CW
 - · Continuous mode
 - Frequency: Channel 18
- 2. Set analyzer to:
 - Center frequency = 2.44 GHz
 - Span = 1 MHz
 - Ref amp = 20 dBm
- 3. Measure the phase noise at 100 kHz offset frequency:
 - RBW = 10 kHz (40 dBc)

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Results:

- Marker value = -36.4 dBm within 10 kHz RBW
 - Marker delta = 10.0 (-33.8) = 43.8 dB
 - Phase noise at 100 kHz offset = -43.8-10 log (10 kHz) = -83.8 dBc/Hz

Note: Phase noise is for information only.

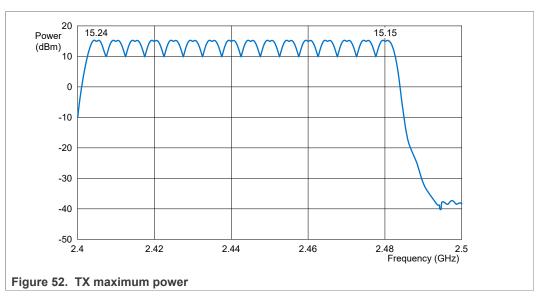
3.3.3.3 TX power (fundamental)

Test method:

- 1. Set the radio in:
 - TX mode
 - Modulated
 - · Continuous mode
- 2. Set analyzer to:
 - Start frequency = 2.4 GHz
 - Stop frequency = 2.5 GHz
 - Ref amp = 20 dBm
 - Sweep time = 100 ms
 - RBW = 3 MHz
- 3. Max Hold mode
- 4. Detector: Peak
- 5. Sweep all the channels from ch11 to ch26

Result:

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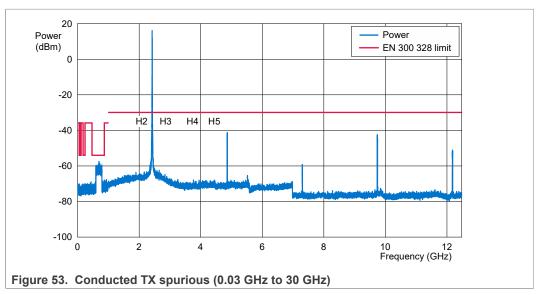
- Maximum power is on channel 12: +15.26 dBm
- Minimum power is on channel 17: +15.14 dBm
- Tilt over frequencies is 0.09 dB

Conclusion:

- The default TX power is in line with the expected results.
- The power is flat over frequency.

3.3.3.4 TX spurious

3.3.3.4.1 Global view from 0.3 GHz to 12.5 GHz (desired = channel 18)



Conclusion:

- There are no TX spurs above the EN 300 328 limit.
- Harmonics are measured in the following paragraphs.

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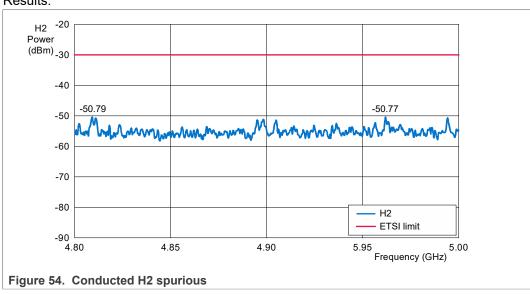
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3.3.3.4.2 H2 (ETSI test conditions)

Test method:

- 1. Set the radio in:
 - TX mode
 - Modulated
 - · Continuous mode
- 2. Set analyzer to:
 - Start frequency = 4.8 GHz
 - Stop frequency = 5 GHz
 - Ref amp = -20 dBm
 - Sweep time = 100 ms
 - RBW = 1 MHz
- 3. Max Hold mode
- 4. Detector: Peak
- 5. Sweep all the channels from ch11 to ch26

Results:



• Maximum power is on channel 26: -50.8 dBm

Conclusion:

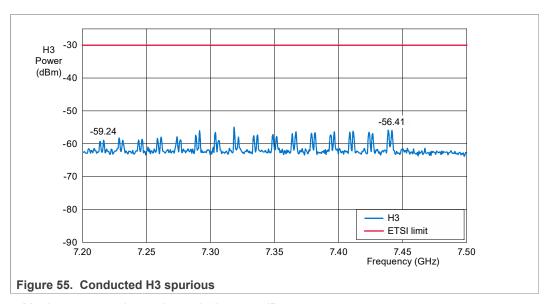
• There is 20.8 dB margin to the ETSI limit.

3.3.3.4.3 H3 (ETSI test conditions)

The test method is the same as for the H2, except the spectrum analyzer frequency start/stop is set to 7.2 GHz and 7.5 GHz.

Results:

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• Maximum power is on channel 18: -55.7 dBm

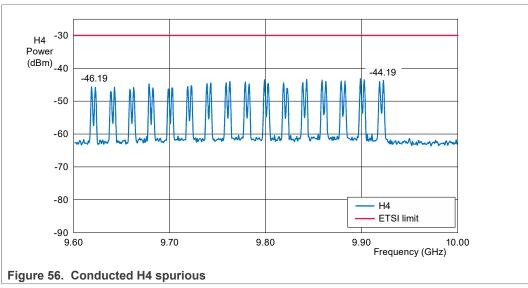
Conclusion:

• There is 25.7 dB margin to the ETSI limit.

3.3.3.4.4 H4 (ETSI test conditions)

The test method is the same as for the H2, except the spectrum analyzer frequency span is set from 9.6 GHz to 10.0 GHz.

Result:



• Maximum power is on channel 25: -43.7 dBm

Conclusion:

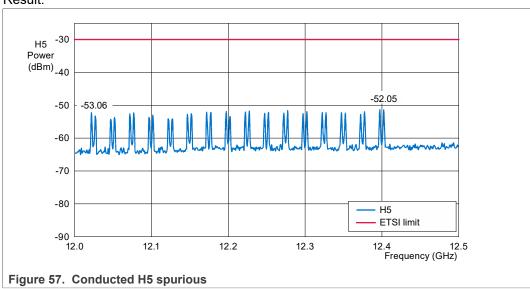
• There is 17.7 dB margin to the ETSI limit.

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3.3.3.4.5 H5 (ETSI test conditions)

The test method is the same as for the H2, except the spectrum analyzer frequency span is set from 12.0 GHz to 12.5 GHz.





• Maximum power is on channel 26: -52.05 dBm

Conclusion:

• There is 22 dB margin to the ETSI limit.

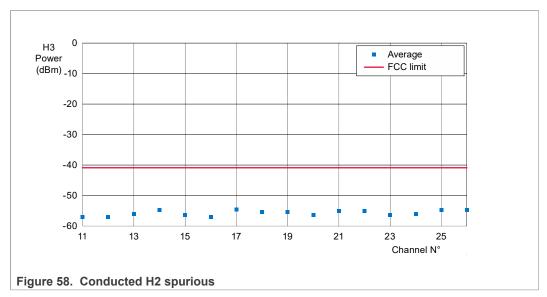
3.3.3.4.6 H2 (FCC test conditions)

Test method:

- 1. Set the radio in:
 - TX mode
 - Modulated
 - · Continuous mode
- 2. Set analyzer to:
 - Start frequency= 4.8 GHz
 - Stop frequency = 5 GHz
 - Ref amp = -20 dBm
 - RF attenuation = Sweep time = 100 ms
 - RBW = 1 MHz
- 3. Trace mode: Average
- 4. Detector: RMS
- 5. Sweep all the channels from ch11 to ch26

Result:

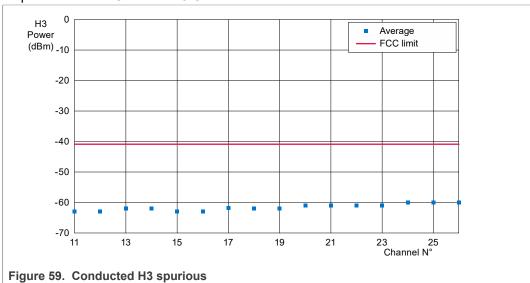
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- Maximum power on channels 14, 17 to 19, 21, 22, 25, 26 is: -55.0 dBm Conclusion:
- There is 14 dB margin to the FCC limit.

3.3.3.4.7 H3 (FCC test conditions)

The test method is similar as for the H2, except the spectrum analyzer frequency start/ stop are set to 7.2 GHz and 7.5 GHz.



Results:

• Maximum power is on channels 24 to 26: -60 dBm

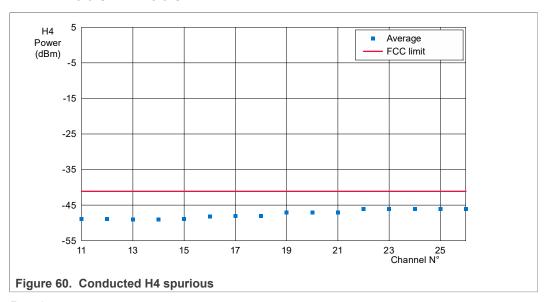
Conclusion:

• There is 19 dB margin to the ETSI limit.

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3.3.3.4.8 H4 (FCC test conditions)

The test method is the same as for the H2, except the spectrum analyzer frequency span is set from 9.6 GHz to 10.0 GHz.



Results:

• Maximum power is on channels 22 to 26: -46 dBm

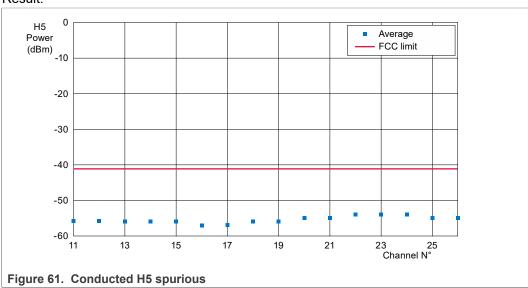
Conclusion:

• There is 5 dB margin to the FCC limit.

3.3.3.4.9 H5 (FCC test conditions)

The test method is the same as for the H2, except the spectrum analyzer frequency span is set from 12 GHz to 12.5 GHz.

Result:



Maximum power is on channel 13: -54 dBm

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Conclusion:

There is 13 dB margin to the FCC limit.

3.3.3.4.10 Other harmonics (FCC test conditions)

The test method is similar as for the H5. H6, H7, H8, H9, H10 are measured on another spectrum analyzer (capable to measure up to 30 GHz) frequency span that is set accordingly.

Result:

- -67 dBm < H6 < -63 dBm
- -75 dBm < H7 < -70 dBm
- H8 is at -75 dBm
- -71 dBm < H9 < -69 dBm
- -70 dBm < H10 < -68 dBm

Conclusion:

- For H6, there is 22 dB margin to the FCC limit.
- For H7, there is 29 dB margin to the FCC limit.
- For H8, there is 34 dB margin to the FCC limit.
- For H9, there is 28 dB margin to the FCC limit.
- For H10, there is 27 dB margin to the FCC limit.

3.3.3.5 TX modulation

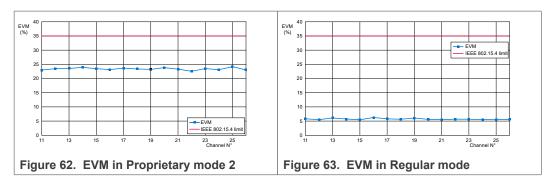
3.3.3.5.1 EVM

Test method:

- Connect the RF port of the module to the R&S FSV30 spectrum analyzer. To do the EVM measurement, use the specific menu of the SA.
- · Set the K32W in continuous Modulated mode
- Set the TX frequency to channel 11
- · Measure the offset EVM value
- · Repeat the test for each channel

Filtering the spectrum with Proprietary mode 1 or Proprietary mode 2 affects the EVM and offset EVM.

The following graphs show the EVM value for both the Proprietary mode 2 and the Regular mode.



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Result:

- Proprietary mode 2 maximum value on channel 25 = 24.2 %
- Regular mode maximum value on channel 26 = 6.3 %

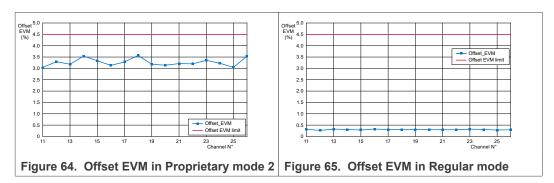
Conclusion:

Very good margin vs IEEE 802.15.4 limit in Regular mode.
 Note: Although the EVM is degraded in Proprietary mode 2, there is still good margin to IEEE 802.15.4 limit.

3.3.3.5.2 Offset EVM

Test method:

· The test method is same as for the EVM measurement



Result:

- Proprietary mode 2 maximum value on channel 18 = 3.57 %
- Regular mode maximum value on channel 23 = 0.34 %

Conclusion:

• Very good margin vs K32W specification in Regular mode.

Note: Although the offset EVM is degraded in Proprietary mode 2, there is still a good margin to K32W specification.

3.3.3.6 Upper band edge

Test method:

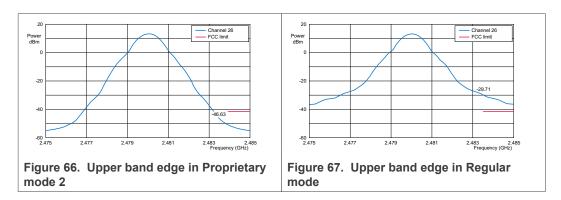
- 1. Set the radio to:
 - TX mode
 - Modulated
 - · Continuous mode
- 2. Set the analyzer to:
 - Start frequency = 2.475 GHz
 - Stop frequency = 2.485 GHz
 - Ref amp=-20 dBm
 - Sweep time=100 ms
 - RBW = 1 MHz
 - VBW = 3 MHz
 - Detector = Average
 - Average mode: Power

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- Number of sweeps = 100
- Set the channel 26 (2.48 GHz)

Result:



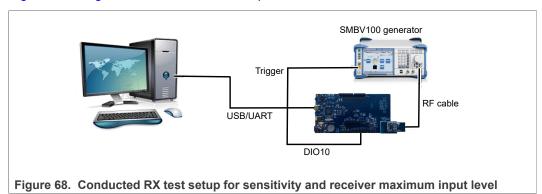
Conclusion:

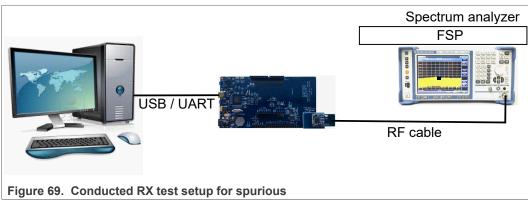
• The upper band edge test passes the ETSI certification in the Proprietary mode 2.

3.4 RX tests

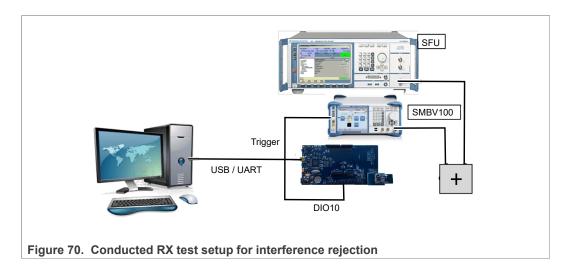
3.4.1 Test setup

Figure 68 to Figure 70 shows the test setups conducted for RX.





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3.4.2 RX sensitivity

Test method:

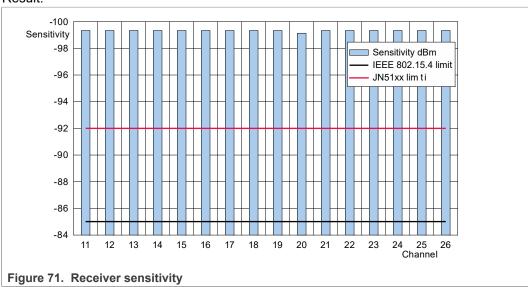
The carrier board and K32W module are placed in an RF shield box to avoid any interference.

Generator: R&S SMBV100

The generator is used in ARB mode. It generates a pattern of 1000 packets of 20 octets. The DIO10 of the K32W is connected to the trigger input of the generator. A TERATERM window is used to control the module.

- Set the receive frequency to channel 11
- Set the module in trigger packet test
- The connection is automatically established and the Packet Error Rate (PER) is measured
- Decrease the level of the generator at the RF input of the module until PER = 1 %

Result:



Conclusion:

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• Minimum value: - 99.5 dBm on channels 11 to 16, 19, 25

Maximum value: -99.2 dBm on channel 20

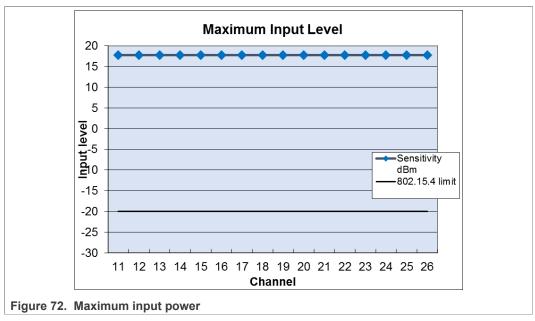
3.4.3 Receiver maximum input level

Test method:

Generator: R&S SMBV100

The generator is used in ARB mode. It generates a pattern of 1000 packets of 20 octets. The DIO10 of the K32W is connected to the trigger input of the generator. A TERATERM window is used to control the module.

- Set the receive frequency to channel 11
- · Set the module in trigger packet test
- The connection is automatically established and the PER is measured
- Increase the level of the generator at the RF input of the module until PER = 1 %
- · Do the same for other channels



Conclusion:

- The actual maximum input level cannot be measured with the test environment. The maximum level that can be delivered to the K32W is limited by the maximum output power of the generator and the cable losses.
- The maximum input level of K32W is higher than 17.8 dBm on all channels.

3.4.4 RX spurious

3.4.4.1 Wide band

Test method:

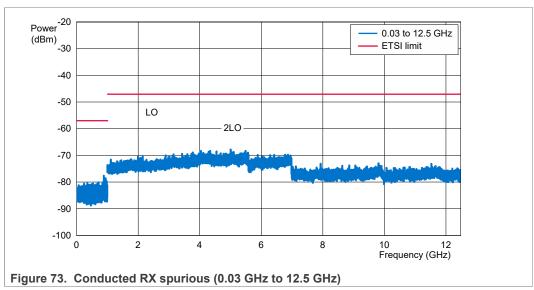
- 1. Set the radio in:
 - · Receiver mode

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- Frequency: Channel 18
- 2. Set the analyzer to:
 - Ref amp = -20 dBm
 - Trace = Max Hold
 - Detector = Max Peak
 - Start/stop frequency: 30 MHz/1 GHz, RBW = 100 kHz
 - Start/stop frequency: 1 GHz/12.75 GHz, RBW = 1 MHz

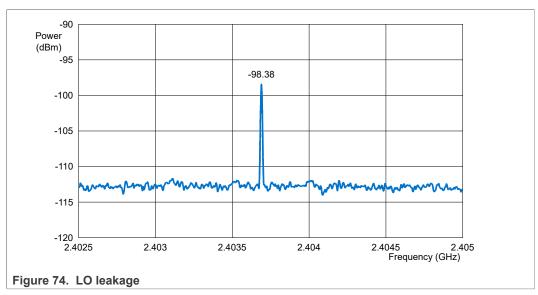
Result:



Note: No spur has been detected.

3.4.4.2 LO leakage

Test frequency: 2440 MHz (channel 18)



Result:

• -98.4 dBm

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Conclusion:

51.4 dB margin to ETSI limit.

3.4.5 Receiver interference rejection

3.4.5.1 Adjacent and alternate channels with standard interferers

Interferers are located in the adjacent channel (n-1 and n+1) or alternate channels (n-2 and n+2). The test is performed with only one interfering signal at a time.

Test method:

Generator for desired signal: Rohde&Schwarz SMBV100A generator (modulated)

Generator for interferers: R&S SFU (modulated)

Criterion: PER < 1 %

The desired signal is set to -82 dBm. The interferer is increased until the PER threshold has been reached.

Channels under test: 11, 18 and 26 (although n-1, n-2 are not system relevant for channel 11 and n+, n+2 are not system relevant for channel 26).

Results:

	ch11						
	2405						
	n-2 n-1 n+1 n+2						
	2395	2400	2410	2415			
Interferer level (dBm)	-35.6	-46.5	-45.7	-35.4			
Interferer level (dBc)	46.4	35.5	36.3	46.6			
IEEE 802.15.4 limit (dB)	30	0	0	30			
Margin (dB)	16.4	35.5	36.3	16.6			

ch18								
	2440							
n-2	n-1	n+1	n+2					
2430	2435	2445	2450					
-35.6	-46.5	-45.7	-35.2					
46.4	35.5	36.3	46.8					
30	0	0	30					
16.4	35.5	36.3	16.8					

ch26								
2480								
n-2	n-1	n+1	n+2					
2470	2475	2485	2490					
-35.6	-46.5	-45.5	-35.2					
46.4	35.5	36.5	46.8					
30	0	0	30					
16.4	35.5	36.5	16.8					

Figure 75. Adjacent and alternate rejection

Conclusion:

• Good margin, in line with the expected results.

3.4.5.2 N-3 and N+3 channels with standard interferers

Test method:

The test method is same as for the adjacent and alternate channels but the interferer is set at +/-15 MHz offset from the desired channel.

Results:

	ch	11
	24	05
	n-3	n+3
	2390	2420
Interferer level (dBm)	-30.3	-30.3
Interferer level (dBc)	51.7	51.7
Datasheet typical value (dB)	48	48
Margin (dB)	3.7	3.7

ch18					
2440					
n-3	n+3				
2425	2455				
-30.3	-30.3				
51.7	51.7				
48	48				
3.7	3.7				

ch26					
24	80				
n-3	n+3				
2465	2495				
-30.3	-30.3				
51.7	51.7				
48	48				
3.7	3.7				

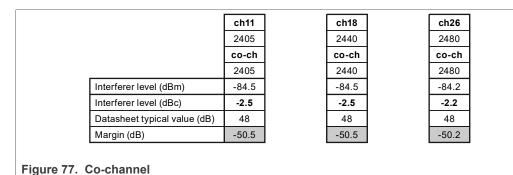
Figure 76. N-/+3 band rejection

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Conclusion:

· In line with the expected values

3.4.5.3 Co-channel



Conclusion:

In line with expected values

3.4.5.4 Adjacent and alternate channels with filtered interferers (as generated by a K32W in Proprietary mode 2)

Interferers are located in the adjacent channel (n-1 and n+1) or alternate channels (n-2 and n+2). The test is performed with only one interfering signal at a time.

Test method:

Generator for desired signal: Rohde&Schwarz SMBV100A generator (modulated)

Generator for interferers: R&S SFU (modulated and filtered frame)

Criterion: PER < 1 %

The desired signal is set to -82 dBm. The interferer is increased until the PER threshold has been reached.

Channels under test: 11, 18 and 26 (although n-1, n-2 are not system relevant for channel 11 and n+, n+2 are not system relevant for channel 26).

Results:

	ch11 2405				ch18 2440			ch26				
									2480			
	n-2	n-1	n+1	n+2	n-2	n-1	n+1	n+2	n-2	n-1	n+1	n+2
	2395	2400	2410	2415	2430	2435	2445	2450	2470	2475	2485	2490
Interferer level (dBc)	62.2	58.2	59.7	62.2	62.2	58.2	59.2	62.2	62.7	58.2	59.7	63.2
IEEE 802.15.4 limit (dBm)	30	0	0	30	30	0	0	30	30	0	0	30
Margin (dB)	32.2	58.2	59.7	32.2	32.2	58.2	59.2	32.2	32.7	58.2	59.7	33.2

Conclusion:

• By using K32W to build a network that transmits in Proprietary mode 2, we can improve the immunity to alternate interferers by 23 dB and the immunity to alternate interferers by more than 15 dB.

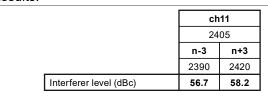
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3.4.5.5 N-3 and N+3 channels with filtered interferers (as generated by a K32W in Proprietary mode 2)

Test method:

The test method is same as for the adjacent and alternate channels but the interferer is set at +/-15 MHz offset from the desired channel.

Results:



ch18				
2440				
n-3	n+3			
2425	2455			
56.7	59.2			

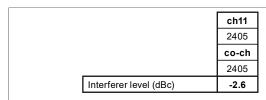
ch26			
2480			
n-3	n+3		
2465	2495		
57.2	59.2		

Figure 79. N-/+3 band rejection

Conclusion:

• By using K32W to build a network that transmits in proprietary mode 2, we can improve immunity to n-3 or n+3 interferers by more than 16 dB.

3.4.5.6 Co-channel with a filtered interferer



ch18 2440 co-ch 2440 -2.6 ch26 2480 co-ch 2480 -2.6

Figure 80. Co-Channel

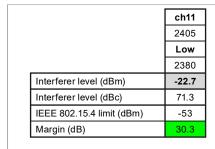
Conclusion:

• There is no significant difference in co-channel when using a standard interferer or a filtered interferer. The results are compliant with the specifications.

3.4.6 Receiver blocking

The K32W is equipment of category 1 as defined by the ETSI 300 328 (TX signal is higher than 10 dBm). Tests and limits are used according to category 1. Interferer is a CW signal.

3.4.6.1 Test 1



2405
High
2503.5
-20.6
73.4
-53
32.4

ch11

ch26 2480 Low 2380 -20.6 73.4 -53

2480
High
2503.5
-23.1
70.9
-53

Figure 81. Receiver blocking test 1

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Conclusion:

Very good margin

3.4.6.2 Test 2

	ch11	ch11	ch11		ch26		ch26		ch26
	2405	2405	2405		2480		2480		2480
	Low	Low	Low		Low		Low		Low
	2300	2330	2360		2300		2330		2360
Interferer level (dBm)	-19.3	-20.1	-21.6		-19.6		-19.9		-20.5
Interferer level (dBc)	74.7	73.9	72.4		74.4		74.1		73.5
IEEE 802.15.4 limit (dBm)	-53	-53	-53		-53		-53		-53
Margin (dB)	33.7	32.9	31.4		33.4		33.1		32.5
•				•		•		•	

Figure 82. Receiver blocking test 2

Conclusion:

Very good margin

3.4.6.3 Test 3

	ch11	ch11	ch11	ch11	ch11	ch11
	2405	2405	2405	2405	2405	2405
	High	High	High	High	High	High
	2523.5	2553.5	2583.5	2613.5	2643.5	2673.5
Interferer level (dBm)	-20.1	-20.4	-20.1	-20.1	-19.8	-19.9
Interferer level (dBc)	73.9	73.6	73.9	73.9	74.2	74.1
IEEE 802.15.4 limit (dBm)	-53	-53	-53	-53	-53	-53
Margin (dB)	32.9	32.6	32.9	32.9	33.2	33.1
	2480	2480	2480	2480	2480	2480
	2480	2480	2480	2480	2480	2480
	1 111 1					1111.11
	High	High	High	High	High	High
	2523.5	2553.5	2583.5	2613.5	2643.5	2673.5
Interferer level (dBm)	\vdash	<u> </u>	⊢ •	⊢ —	⊢ ∸⊢	
Interferer level (dBm) Interferer level (dBc)	2523.5	2553.5	2583.5	2613.5	2643.5	2673.5
	2523.5 -21.5	2553.5 -21.0	2583.5 -20.6	2613.5 -20.2	2643.5 -19.8	2673.5 -19.9

Conclusion:

• Very good margin

3.4.7 Packet Error Rate (PER) versus RX input power

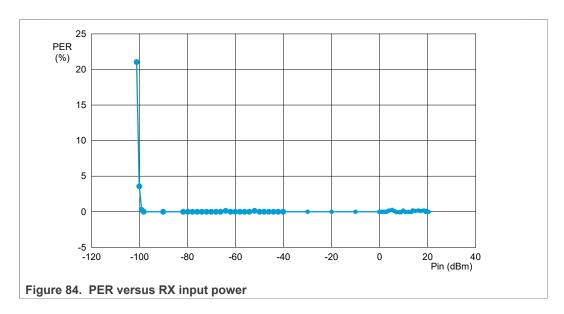
PER value is picked up when input power is decreased.

Test method:

Generator for desired signal: Rohde&Schwarz SMBV100A generator

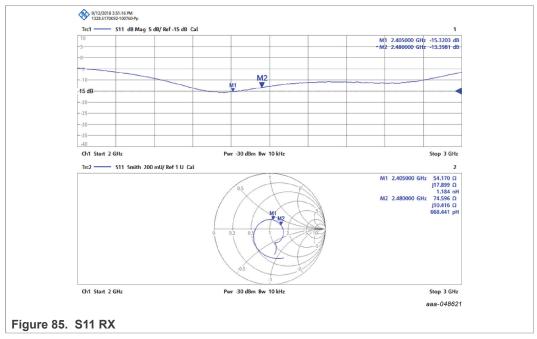
Results:

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3.5 Return loss

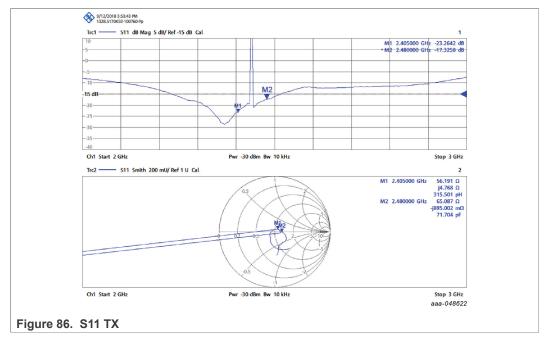
3.5.1 RX return loss



S11 < -12 dB at 2.405 - 2.480 GHz

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3.5.2 TX return loss



S11 < -17 dB at 2.405 - 2.480 GHz

Conclusion:

The S11 TX and RX are better than the NXP -10 dB target.

Note: There is no specification for the return loss.

On a module with a SMA connector instead of a μ FI connector, the return loss is improved by 1 dB in the same network.

3.6 Conclusion

Beyond RED, 802.15.4, and FCC compliance, these radio tests prove the good RF performances of the K32W041AM.

Due to high spectral density, it is recommended to target FCC certification only.

4 Benefits of Proprietary mode

The benefit of using a Proprietary mode in a Zigbee network:

- Consider a K32W configured in ZigBee RX mode, while a second K32W generates the desired channel when configured in ZigBee TX mode.
- Consider that a third K32W is configured in Transmit mode and generates an interferer ZigBee in a near-by channel.
- The side lobes of the ZigBee modulation in this case limit the interferer immunity of the K32W receiver if the interferer signal is generated without any filtering.
- The K32W radio has better performances in terms of interferers immunity compared
 to the side lobes limitation of the ZigBee modulation. Therefore, using the Proprietary
 mode for the transmitter that generates the interferer improves the interferer immunity
 of the K32W which is configured in RX mode.

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• Alternatively, when the K32W interferer uses the Proprietary mode as opposed to the Regular mode, the level of the interferer can be higher relative to the desired channel.

5 CMET settings

This section includes CMET settings for the tests presented in this application note.

1. For tests in Transmit mode:

Section	CMET selection	CMET evaluation software
Section 3.3.3.1 Frequency accuracy	b) a) a)	**************************************
Section 3.3.3.2 Phase noise at 100 kHz offset	b) a) a)	* Radio Test version 2042
Section 3.3.3.3 TX power fundamental	b) a) a) +/-	a) Standard HITM power Module // Reset CMET Please choose an option >b Standard HITM power Module in High TX mode Selected
Section 3.3.3.4 TX spurious	b) a) b) a)	** ZigBee Mode *
Section 3.3.3.5 TX modulation	b) a) b) a)	a) Regular
Section 3.3.3.5.1 EVM	b) a) b) a) +/-	b) Proprietary 1 c) Proprietary 2 d) Regular with flash write/read in test
Section 3.3.3.5.2 Offset EVM	b) a) b) a) +/-	Please choose an option >a ZigBee Regular Mode Selected
Section 3.3.3.6 Upper band edge	b) a) b) a) Ch26	* Customer Module Evaluation Tool *
Section 3.5.2 TX return loss	b) a) b) a)	* Radio Tests * a) TX Power Test (CH) b) TX Power Test (CH) b) TX Power Test (Modulated) c) Receive Test (Modulated) d) Oscillator Frequency Test d) Oscillator Frequency Test f) RF Power Measurement g) Trigger Packet Test h) Receive Packet Test h) Receive Packets Test j) Connectionless Packet Error Rate Test k) CCR Test 1) Transmit Packets Test j) Lonnectionless Packet Error Rate Test k) CCR Test 1) LQ1 Test n) Turnaround Tests

2. For tests in Receive mode:

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Section	CMET selection	CMET evaluation software
Section 3.5.1 RX return loss	b) a) h)	**************************************

3. For PER test:

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Section	CMET selection	CMET evaluation software
Section 3.4.2 RX sensitivity	b) a) g) 'A' 'g' +/-	* Customer Module Evaluation Tool * * Version 2041 *
Section 3.4.3 Receiver maximum input level	b) a) c)	* Compiled Sep 21 2020 14:14:53
Section 3.4.4 RX spurious • Section 3.4.4.1 Wide band • Section 3.4.5.1 Adjacent and alternate channels with standard interferers • Section 3.4.5.2 N-3 and N+3 channels with standard interferers • Section 3.4.5.3 Co-channel • Section 3.4.5.4 Adjacent and alternate channels with filtered interferers (as generated by a K32W in Proprietary mode 2) • Section 3.4.5.5 N-3 and N+3 channels with filtered interferers (as generated by a K32W in Proprietary mode 2) • Section 3.4.5.6 Co-channel with a filtered interferer Section 3.4.6 Receiver blocking	b) a) c)	* Chip ID 000e2117 ** *********************************
		(default = A)

6 K32W_certi_tool settings

This section includes K32W_certi_tool settings for the tests presented in this application note.

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1. For tests in Transmit mode:

Section	K32W_certi_tool selection	Certi_tool evaluation software
Section 2.3.2.1 Frequency accuracy	[1], [7]	
Section 2.3.2.2 Phase noise	[1], [7]	
Section 2.3.2.3 TX power (fundamental)	[1], [7], [q] or [w]	
Section 2.3.2.4 TX power in band	[1], [2], [t] or [r]	-Press enter to start K324/(96958383(T) Certi Tools vi.0.6(2093)
Section 2.3.2.5 TX spurious	[1], [2], [t] or [r]	-Press [1] Tx test -Press [2] Ex test -Press [1] Excest HCU K33W/09090830(T) Certi Tools/
Section 2.3.2.6 Upper band edge	[1], [2], [t] or [r], [q] up to channel 39	[11] 28 [4] Dh+ [4] Pu+ [6] Pujd4- [7] 28 [4] Dh- [2] Pu- [6] Pujd4-
Section 2.3.2.7 Modulation characteristics	[1], [2], [t] or [r], [q] or [w] on CMW equipment	Tx Test Menu Press (1) Test End Press (2) Tresmission using PRSSS vandor-pagload packets Press (3) Contracts the description of the description
Section 2.3.2.8 Carrier frequency offset and drift	On CMW equipment (CMWrun)	-Press (1) Continuous Robulator International Press Press (1) Continuous Robulator Transmission (0) 5 - Press (1) Continuous Robulator Transmission (0) 5 - Press (1) Continuous Robulator Transmission (0) 5 - Press (1) Pressional Press (1) Pression Robulator Transmission (1) 5 - Press (1) Pression Robulator Robulator Robulator (1) 5 - Press (1) Pression Robulator Robulator (1) 5 - Press (1) Pression Robulator Robulator (1) 5 - Press (1) Pression Robulator Robulator (1) 5 - Press (1) 5 - P

2. For tests in Receive mode:

Section	K32W_certi_tool selection	Certi_tool evaluation software
Section 3.5.1 RX return loss	[2], [2]	COM14 - Tera Term VT File Edit Setup Control Window Help Salect the Test to perform Press (12) Ex test Press (12) Ex test Press (12) Ex test Press (12) Ex test Dannel 1, Payload 37, PNY 18, Power D. Lit 18 (a) Dr. (a) Pre in a) Pijde Lit 18 (a) Dr. (a) Pre in a) Pijde Ex Test Mou Press (11) Ex trijaper node test Press (22) Ex continuous node test Press (20) Ex Test Mou Ex Test Mou Press (20) Ex T

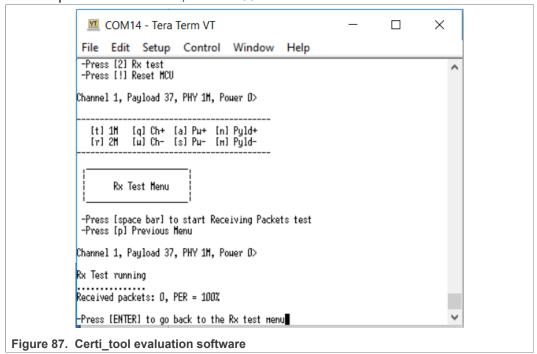
3. For PER test:

Section	K32W_certi_tool selection	Certi_tool evaluation software
Section 2.4.2 RX sensitivity Section 2.4.3 Receiver maximum input level Section 2.4.4 RX spurious • Section 2.4.5.1 Adjacent, alternate, and co-channel rejection • Section 2.4.5.2 Receiver blocking • Section 2.4.5.3 Intermodulation	[2], [q] or [w], [t] or [r], space bar	COM14 - Tera Term VT

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Signal generator sends the packets to the K32W device. Then, the packets received by the K32W device are counted during 15 seconds and ratio of **packets received** to **sent packets** is calculated and displayed.

If no packets are received, PER is 100 % as follows:



7 References

- FCC: 47 CFR Part 15C
- RED: European Radio Equipment Directive applied from June 2016
- **R&TTE**: Radio and Telecommunications Terminal Equipment Directive (R&TTED) (1999/5/EC) has been stopped on June 2016.
- ETSI EN 300 328: European Telecommunication Standard Radio Equipment and Systems (RES) wideband data transmission systems, technical characteristics, and test conditions for data transmission equipment operating in the 2.4 GHz ISM band, using spread spectrum modulation techniques
- IEEE 802.15.4: IEEE standard for Information technology Telecommunications and information exchange between systems – Local and metropolitan area networks – Specific requirements – Part 15.4: Wireless Medium Access Control (MAC) and Physical Layer (PHY) Specifications for Low Rate Wireless Personnel Area Networks (LR-WPANs)
- **RF-PHY TS 4.2.0/5.0**: Bluetooth Test Specification. This document defines test structures and procedures for qualification testing of Bluetooth implementations of the Bluetooth Low Energy RF PHY.
- FCC Part 15: Operation to FCC Part 15 is subject to two conditions. First, the device may not cause harmful interference and, second, the device must accept any interference received, including interference that may cause undesired operation. Hence, there is no guaranteed quality of service when operating a Part 15 device.

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8 Revision history

The <u>Table 17</u> lists the substantive changes done to this document since the initial release.

Table 17. Revision history

Revision number	Date	Substantive changes
0	16 November 2022	Initial release

K32W041AM RF Report for Bluetooth LE and IEEE 802.15.4 Applications

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